

JUAS 2019 RF lab introduction

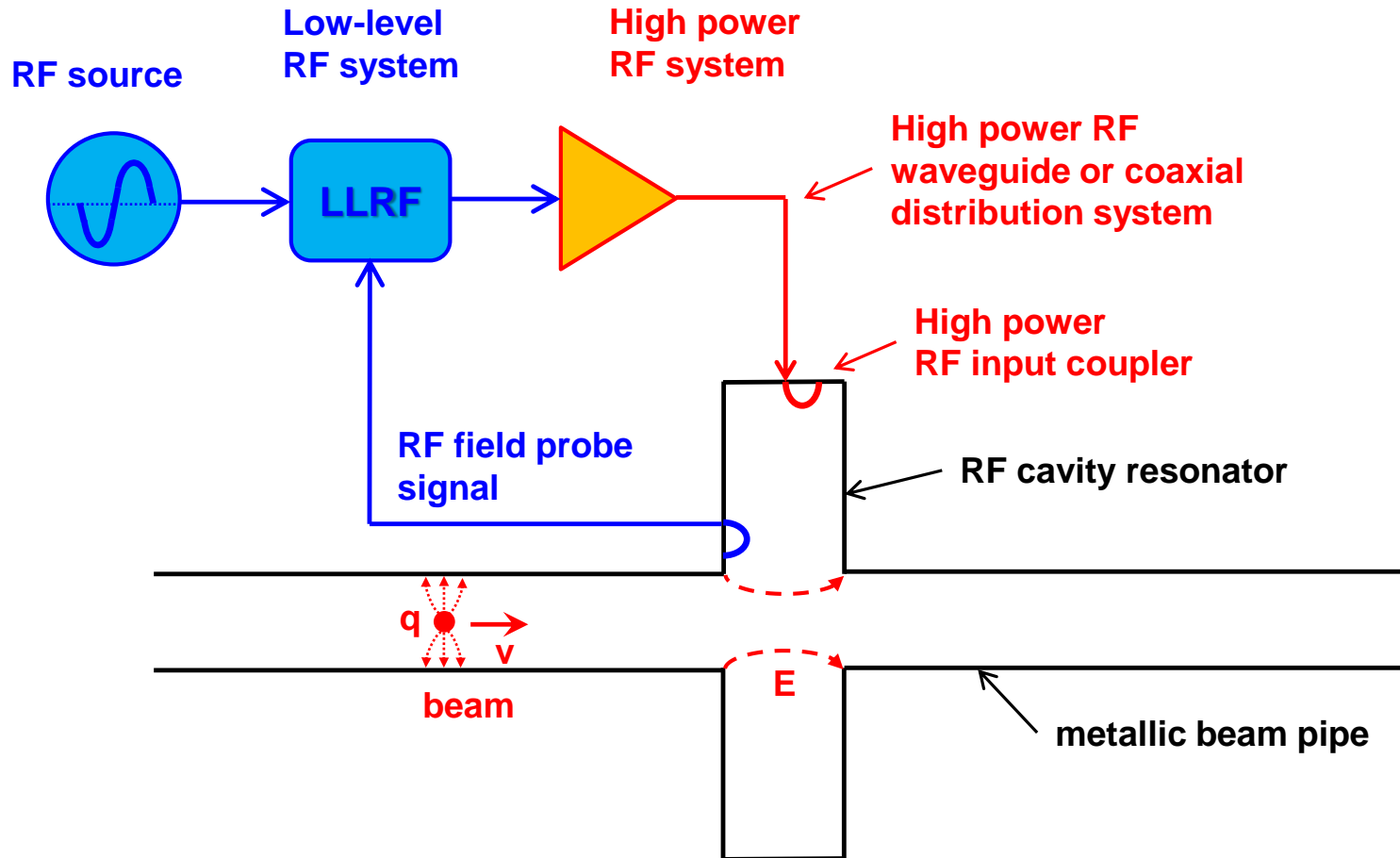


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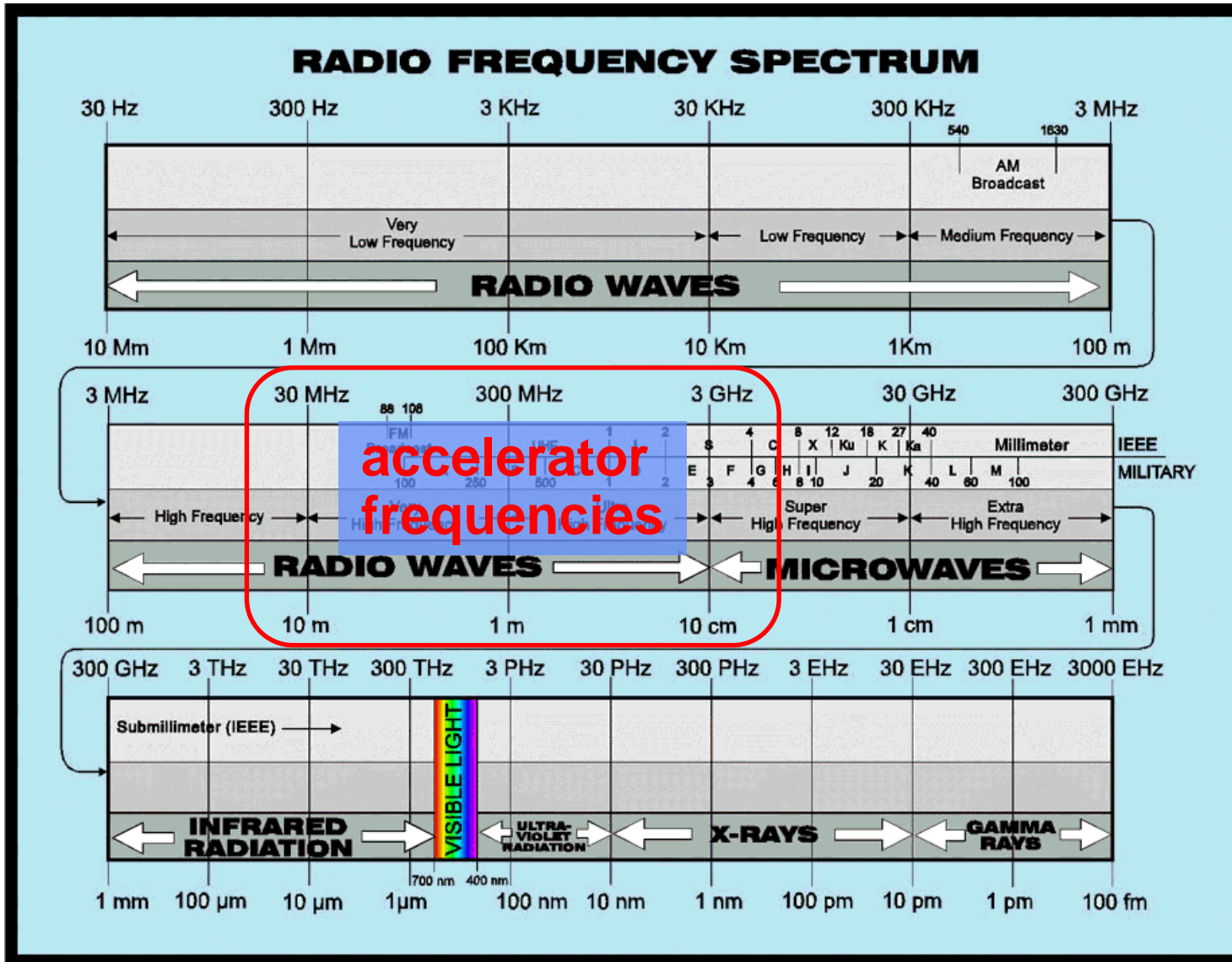
- ◆ RF measurement methods – overview
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- ◆ What awaits you?!

Introduction – Simple RF System



Things get a bit more complicated in the real world: pulsed power RF, multi-cell resonators or traveling wave structures, non-relativistic beams, HOM's, etc.

What are Radio Frequencies?



Free space wavelength:

$$\lambda = \frac{c_0}{f}$$

We care about RF concepts if the physical dimensions of an apparatus is $> \lambda/10$

Measurement methods - overview (1)

There are many ways to observe RF signals. Here we give a brief overview of the five main tools we have at hand

- ◆ Oscilloscope: to observe signals in time domain
 - periodic signals
 - burst signal
 - application: direct observation of signal from a pick-up, shape of common 230 V mains supply voltage, etc.

- ◆ Spectrum analyser: to observe signals in frequency domain
 - sweeps through a given frequency range point by point
 - application: observation of spectrum from the beam or of the spectrum emitted from an antenna, etc.

Measurement methods - overview (2)

◆ Dynamic signal analyzer (FFT analyzer)

- Acquires signal in time domain by fast sampling
- Further numerical treatment in digital signal processors (DSPs)
- Spectrum calculated using Fast Fourier Transform (FFT)
- Combines **features of a scope and a spectrum analyzer**: signals can be looked at directly in time domain or in frequency domain
- Contrary to the SPA, also the spectrum of non-repetitive signals and transients can be observed
- Application: Observation of tune sidebands, transient behavior of a phase locked loop, etc.

◆ Coaxial measurement line

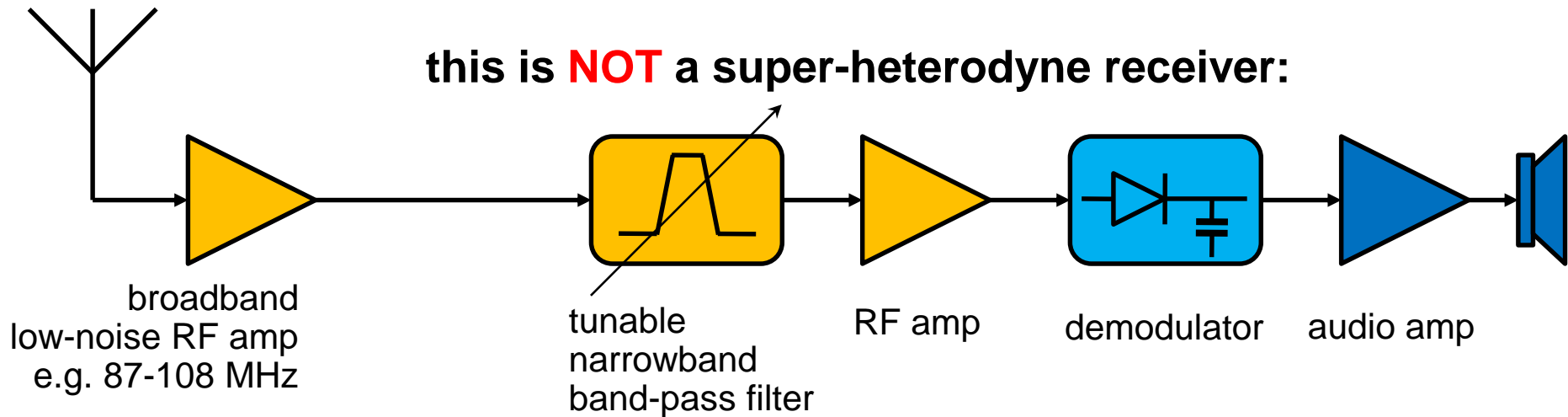
- old fashion method – no more in use but good for understanding of concept

◆ Network analyzer

- Excites a network (circuit, antenna, amplifier or similar) at a given CW frequency and measures response in magnitude and phase => **determines S-parameters**
- Covers a frequency range by measuring step-by-step at subsequent frequency points
- Application: characterization of passive and active components, time domain reflectometry by Fourier transforming reflection response, etc.

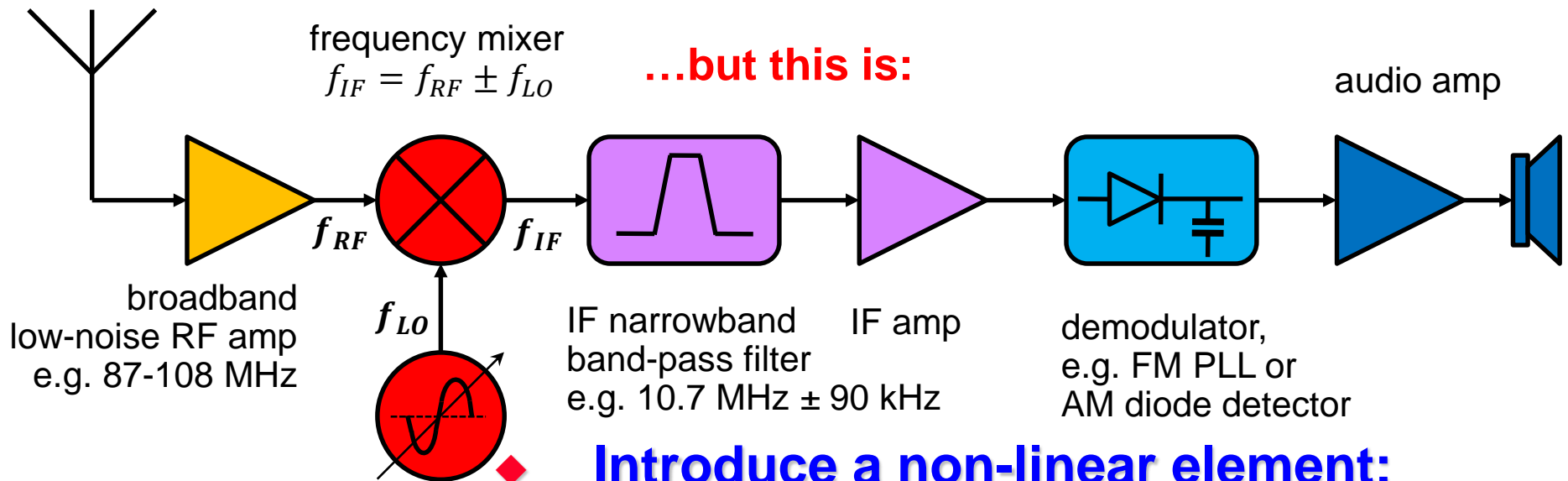
The Super-Heterodyne Receiver (1)

this is **NOT** a super-heterodyne receiver:



- ◆ **...or: 'How does a "traditional" analog radio works?**
 - It was, and still is, difficult to make precisely tunable narrowband, band-pass filters for high frequencies (~100 MHz)!!
 - high frequency low-noise amplifiers are expensive!
 - high frequency demodulators are not trivial.
 - **direct detection of radio and RF signals is challenging!**

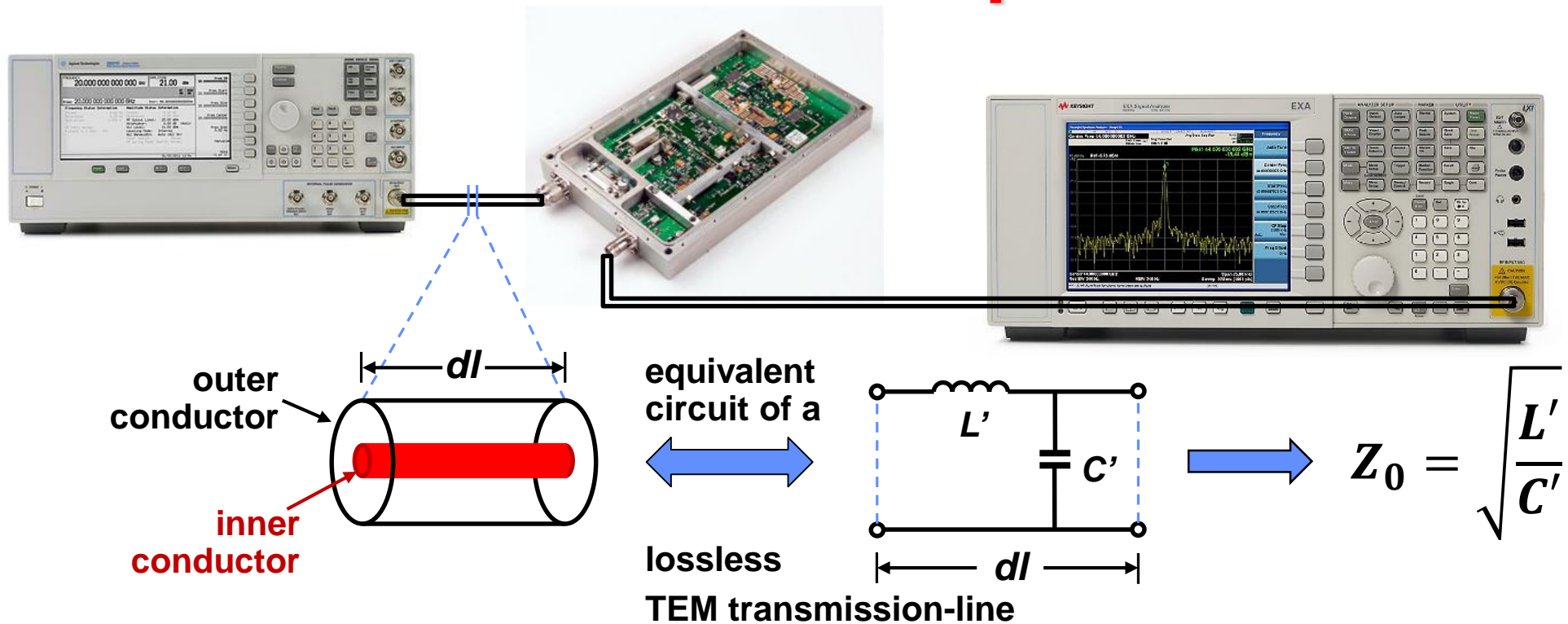
The Super-Heterodyne Receiver (2)



Introduce a non-linear element: the (frequency) mixer!

- "down-convert" the RF band to a fixed "intermediate" frequency (IF) $f_{IF} = f_{RF} \pm f_{LO}$
- requires a tunable local oscillator (LO)
- well manageable IF section:
 - narrowband band-pass filter(s) (BPF) and amplifier(s)
- RF telecommunication standard
- Often multiple mixing stages are used in modern RF instruments, line spectrum analyzers

Characteristic Impedance

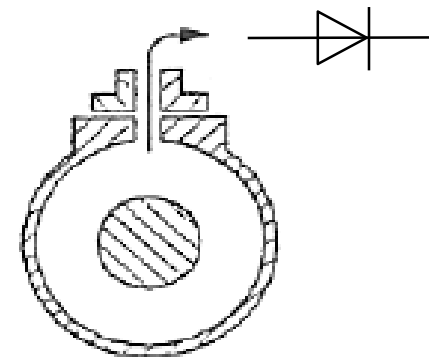
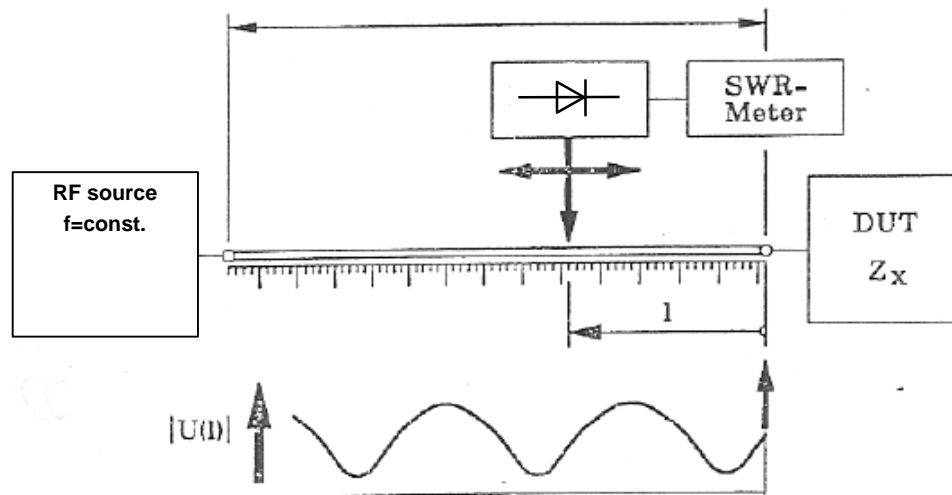


- ◆ The reference impedance Z_0 in a RF system is defined by the characteristic impedance of the interconnect cables
 - often coaxial cables of $Z_0=50\Omega$ (compromise: high voltage / high power handling)
- ◆ The characteristic impedance of a TEM transmission-line is defined by the cross-section geometry
 - Ratio of H- and E-field, represented by L' [H/m] and C' [F/m] in the equivalent circuit of a line segment dl
 - The characteristic impedance Z_0 has the unit Ohm [Ω]

Voltage Standing Wave Ratio VSWR

- ◆ On a transmission-line (single frequency, CW):
 - Superposition of forward a (E^{inc}) and backward b (E^{refl}) traveling waves \Rightarrow standing waves
- ◆ Slotted coaxial air-line is used as standing wave detector
 - Probes the radial electric field along the slotted line.
 - Measurement of E-field minima's E_{min} and maxima's E_{max} with a diode detector, thus detect $|V_{min}|$ and $|V_{max}|$ along the line.
 - Evaluate the reflection coefficient Γ of a DUT of unknown Z_L at the end of the line

$$\Gamma = \frac{E^{refl}}{E^{inc}} = \frac{Z_L - Z_0}{Z_L + Z_0}$$

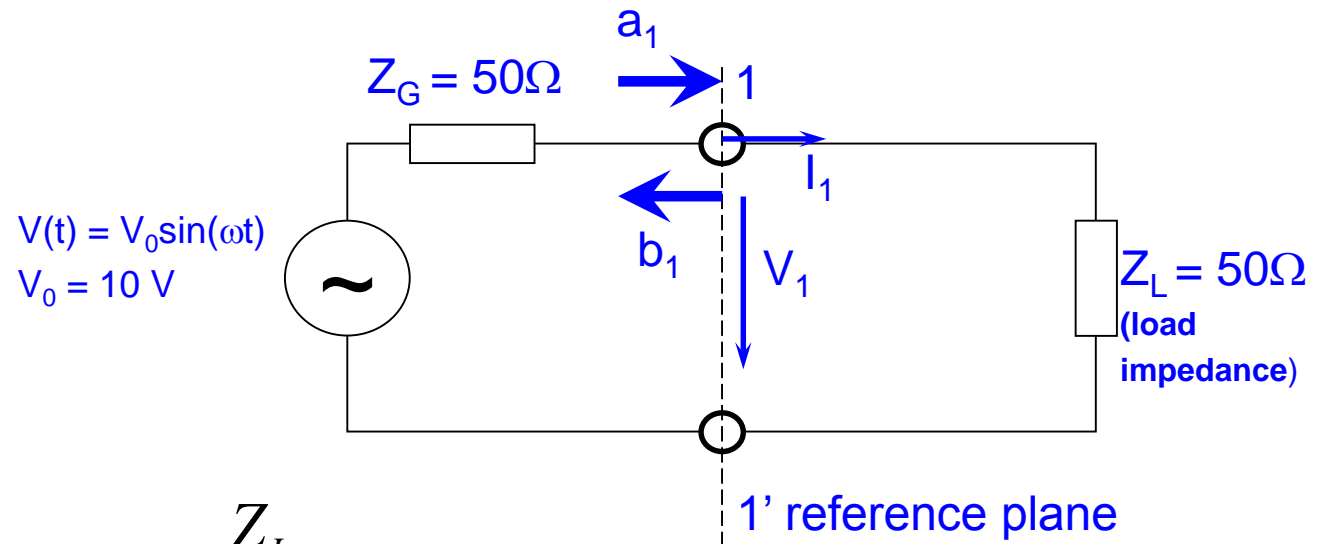


S-Parameters – Introduction

- ◆ **Light falling on a car window:**
 - Some parts of the incident light is reflected (you see the mirror image)
 - Another part of the light is transmitted through the window (you can still see inside the car)
- ◆ **Optical reflection and transmission coefficients of the window glass define the ratio of reflected and transmitted light**
- ◆ **Similar:**
Scattering (S-) parameters of an n -port electrical network (DUT) characterize reflected and transmitted (power) waves

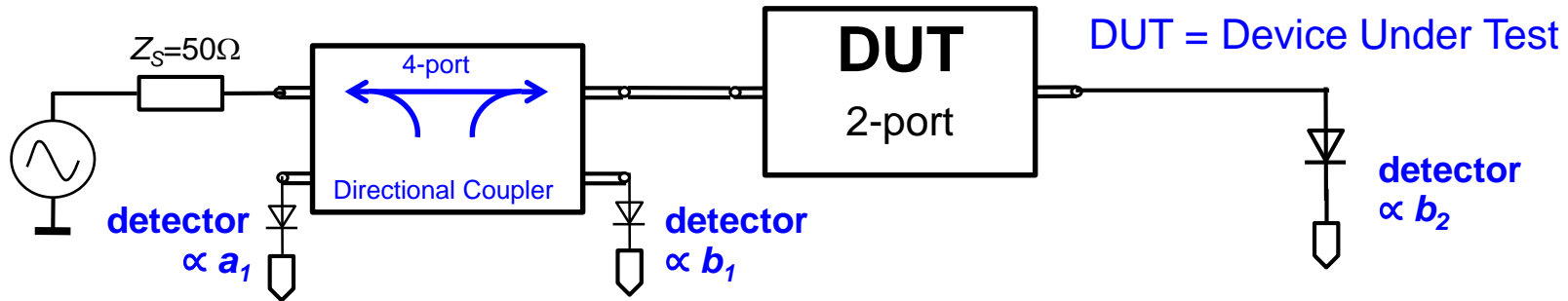


Simple example: a generator with a load



- ◆ Voltage divider: $V_1 = V_0 \frac{Z_L}{Z_L + Z_G} = 5 \text{ V}$
- ◆ This is the matched case i.e. $Z_G = Z_L$.
-> forward traveling wave only, no reflected wave.
- ◆ Amplitude of the forward traveling wave in this case is $V_1 = 5 \text{ V}$;
forward power = $25 \text{ V}^2 / 50 \Omega = 0.5 \text{ W}$
- ◆ Matching means maximum power transfer from a generator with given source impedance to an external load

How to measure S-Parameters?



◆ Performed in the frequency domain

- Single or swept frequency generator, stand-alone or as part of a VNA or SA
- Requires a **directional coupler** and RF detector(s) or receiver(s)

◆ Evaluate S_{11} and S_{21} of a 2-port DUT

- Ensure $a_2=0$, i.e. the detector at port 2 offers a well matched impedance
- Measure incident wave a_1 and reflected wave b_1 at the directional coupler ports and compute for each frequency
- Measure transmitted wave b_2 at DUT port 2 and compute

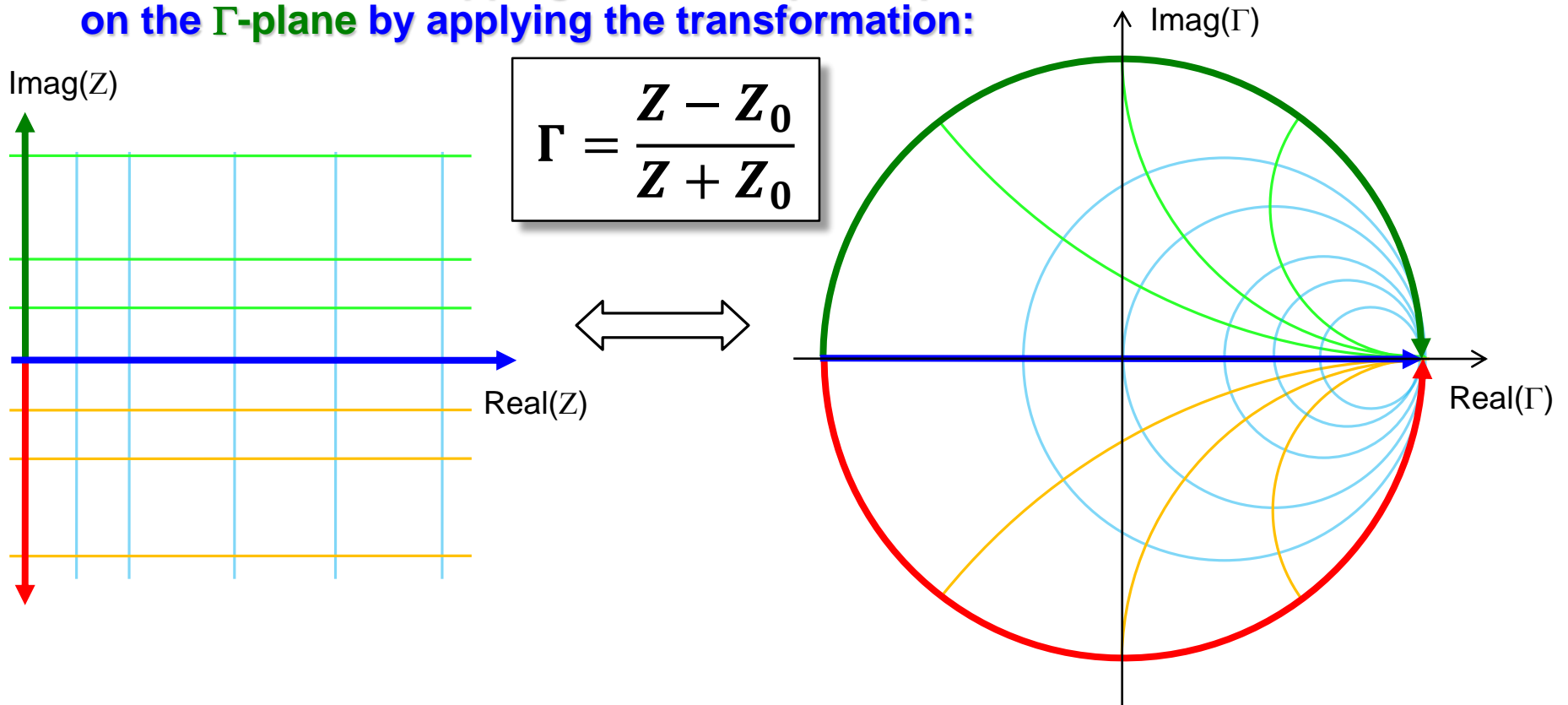
$$S_{11} = \left. \frac{b_1}{a_1} \right|_{a_2=0}$$
$$S_{21} = \left. \frac{b_2}{a_1} \right|_{a_2=0}$$

◆ Evaluate S_{22} and S_{12} of the 2-port DUT

- Perform the same methodology as above by exchanging the measurement equipment on the DUT ports

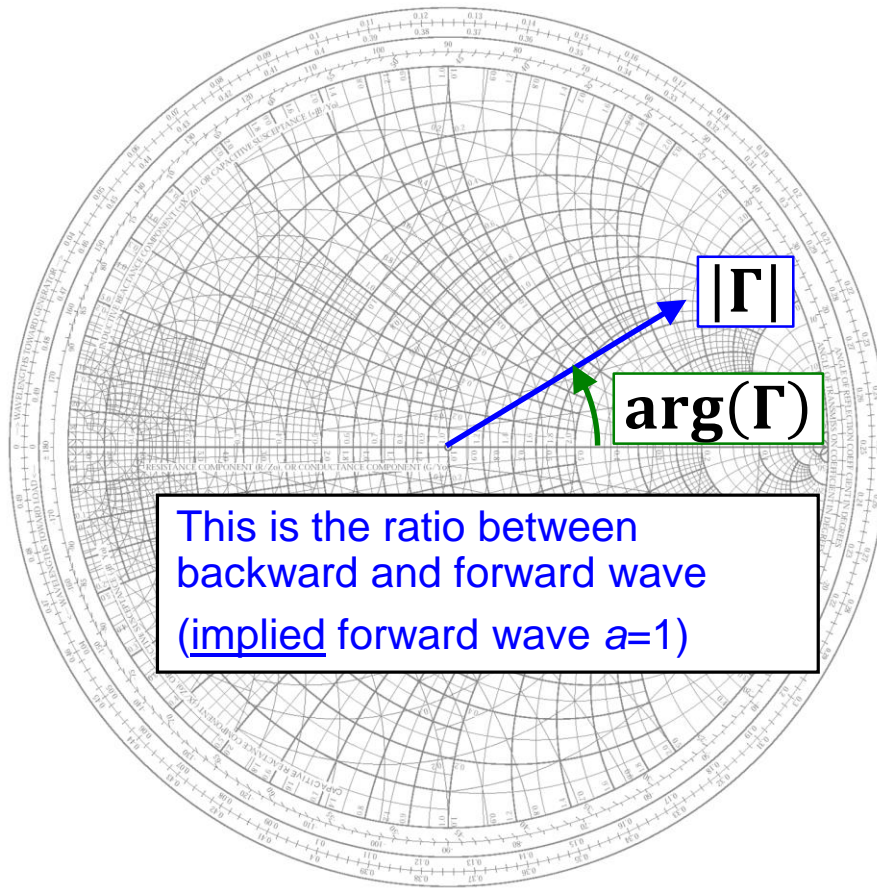
The *Smith Chart* (1)

- ◆ The *Smith Chart* (in impedance coordinates) represents the complex Γ -plane within the unit circle.
- ◆ It is a conformal mapping of the complex Z -plane on the Γ -plane by applying the transformation:



- \Rightarrow the real positive half plane of Z is thus transformed (*Möbius*) into the interior of the unit circle!

The *Smith Chart* (2)



- ◆ In the *Smith chart*, the complex reflection factor

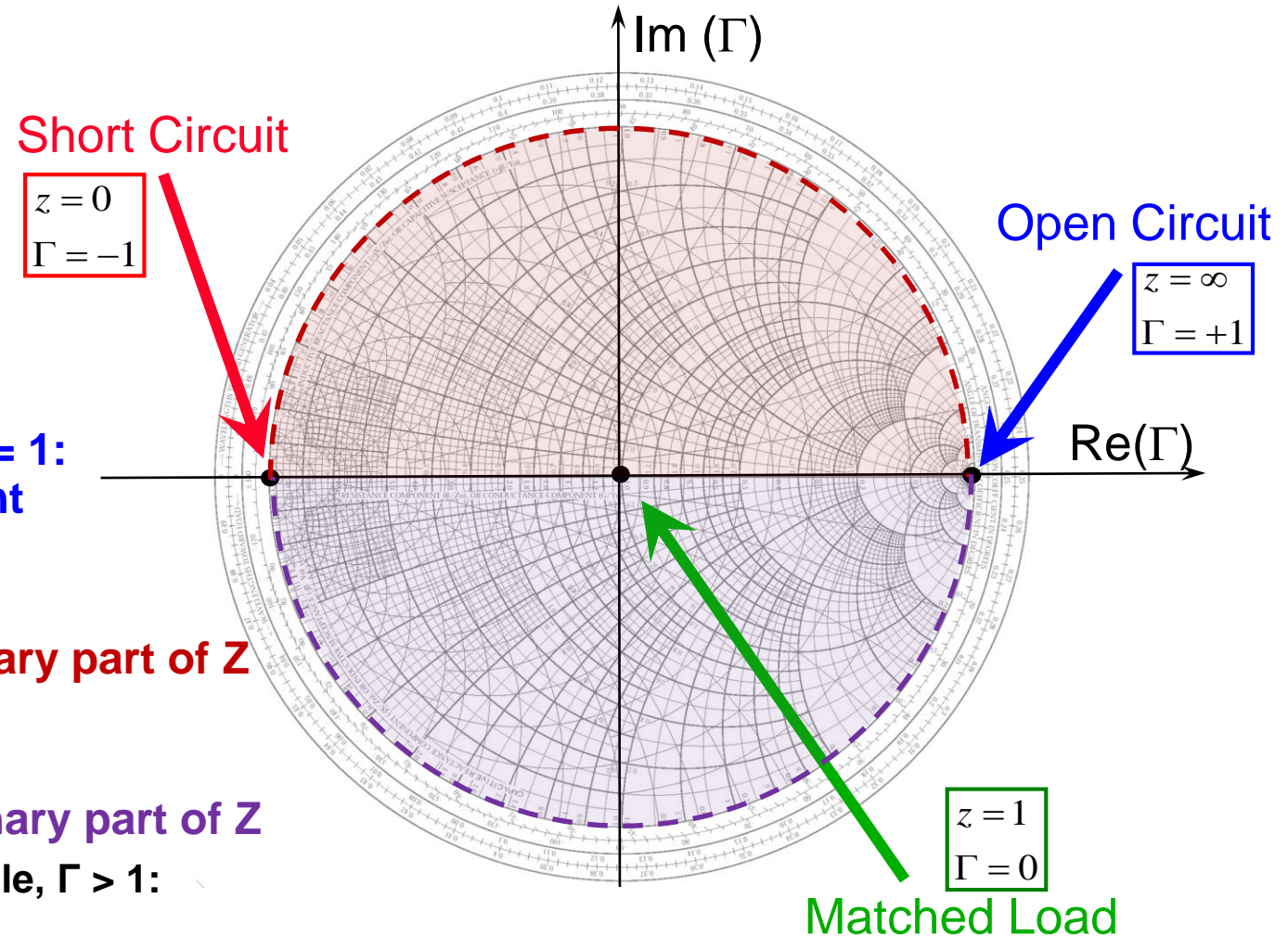
$$\Gamma = |\Gamma|e^{j\varphi} = \frac{b}{a}$$

is expressed in linear cylindrical coordinates, representing the ratio of backward vs. forward traveling waves.

The *Smith Chart* – “Important Points”

Important Points:

- ◆ **Short Circuit**
 $\Gamma = -1, z = 0$
- ◆ **Open Circuit**
 $\Gamma = +1, z \rightarrow \infty$
- ◆ **Matched Load**
 $\Gamma = 0, z = 1$
- ◆ **On the circle $\Gamma = 1$:**
lossless element
- ◆ **Upper half:**
”inductive” =
positive imaginary part of Z
- ◆ **Lower half:**
”capacitive” =
negative imaginary part of Z
- **Outside the circle, $\Gamma > 1$:**
active element,
for instance tunnel diode reflection amplifier



What awaits you?



Photos from RF-Lab
CAS 2009,
Darmstadt

Measurements using Spectrum Analyzer and oscilloscope (1)

- ◆ Measurements of several types of modulation (AM, FM, PM) in the time-domain and frequency-domain.
- ◆ Superposition of AM and FM spectrum (unequal height side bands).
- ◆ Concept of a spectrum analyzer: the superheterodyne method. Practice all the different settings (video bandwidth, resolution bandwidth etc.). Advantage of FFT spectrum analyzers.
- ◆ Measurement of the RF characteristic of a microwave detector diode (output voltage versus input power... transition between regime output voltage proportional input power and output voltage proportional input voltage); i.e. transition between square law and linear region.
- ◆ Concept of noise figure and noise temperature measurements, testing a noise diode, the basics of thermal noise.
- ◆ Noise figure measurements on amplifiers and also attenuators.
- ◆ The concept and meaning of ENR (excess noise ratio) numbers.

Measurements using Spectrum Analyzer and oscilloscope (2)

- ◆ EMC measurements (e.g.: analyze your cell phone spectrum).
- ◆ Noise temperature of the fluorescent tubes in the RF-lab using a satellite receiver.
- ◆ Measurement of the IP3 (intermodulation point of third order) on some amplifiers (intermodulation tests).
- ◆ Nonlinear distortion in general; Concept and application of vector spectrum analyzers, spectrogram mode (if available).
- ◆ Invent and design your own experiment !

Measurements using Vector Network Analyzer (1)

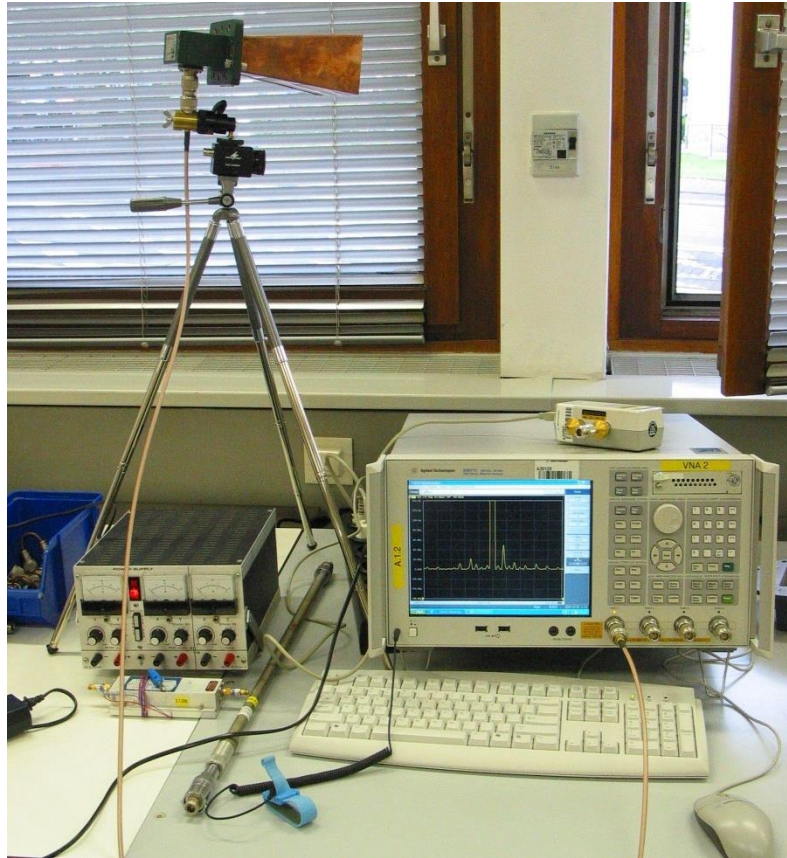
- ◆ N-port ($N=1\dots4$) S-parameter measurements on different reciprocal and non-reciprocal RF-components.
- ◆ Calibration of the Vector Network Analyzer.
- ◆ Navigation in The Smith Chart.
- ◆ Application of the triple stub tuner for matching.
- ◆ Time Domain Reflectometry using synthetic pulse
→ direct measurement of coaxial line characteristic impedance.
- ◆ Measurements of the light velocity using a trombone (constant impedance adjustable coax line).
- ◆ 2-port measurements for active RF-components (amplifiers):
1 dB compression point (power sweep).
- ◆ Concept of EMC measurements and some examples.

Measurements using Vector Network Analyzer (2)

- ◆ Measurements of the characteristic cavity properties (Smith Chart analysis).
- ◆ Cavity perturbation measurements (bead pull).
- ◆ Beam coupling impedance measurements with the wire method (some examples).
- ◆ Beam transfer impedance measurements with the wire (button PU, stripline PU.)
- ◆ Self made RF-components: Calculate build and test your own attenuator in a SUCO box (and take it back home then).
- ◆ Invent and design your own experiment!
(as time allows...)

Invent your own experiment!

Build e.g. Doppler traffic radar
(this really worked in practice during
CAS 2009 RF-lab)



or „Tabacco-box” cavity



or test a resonator of any other type.



You will have enough time to think



and have a contact with hardware and your colleges.



**We hope you will have a lot
of fun...**

